

Notice of References Cited	Application/Control No. 10/587,355		Applicant(s)/Patent Under Reexamination TAKAMATSU ET AL.	
	Examiner SUNIL CHACKO		Art Unit 2625	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,145,682	12-2006	Boldon, John L.	358/1.15
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	M	US-			

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NON-PATENT DOCUMENTS

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